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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/728,108	CHOU ET AL.	
Examiner	Art Unit	
Anthony Fick	1753	

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Class	Subclass	Date	Examiner		
136	253	6/13/2007	ADF		
Vydated	previous	12/11/07	JTB		
					
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SEARCH N (INCLUDING SEARC	CH STRATEGY)
	DATE	EXMR
See EAST search history	6/13/2007	ADF
Inventor search	6/12/2007	ADF _.
Consulted with Nam Nguyen	6/13/2007	ADF